Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/606,023	CHEN ET AL.	
Examiner	Art Unit	
Brian J. Sines	1743	

	SEARCHED				
Class	Subclass	Date	Examiner		
422	50 68.1	1)17/2007	BIS		
	81,82				
	100-103				
436					
	53				
	174,177				
	180				
	i				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST, STN	1/17/2007			
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